



Gallium Nitride 50V, 750W, 2.5-2.7GHz RF Power Transistor

Description

The XTAV27750B4VC is a 750-watt, internally matched GaN HEMT, designed for 5G cellular applications with frequencies from 2.5-2.7GHz, **enabled by wide band VBW capability to support IBW up to 200MHz.**

It can be configured as asymmetrical Doherty for 4G or 5G application, delivering 100W average power, according to normal 8.5dB back off.

There is no guarantee of performance when this part is used in applications designed Outside of these frequencies.

- Typical Doherty Pulsed CW and 1C W--CDMA Characterization Performance:

$V_{DD} = 50 \text{ Vdc}$, $I_{DQA} = 280 \text{ mA}$, $V_{GSB} = -4.9 \text{ Vdc}$,

(1) Pulsed condition: 20us and 10%

(2) 1C WCDMA; Signal PAR = 10 dB @ 0.01% Probability on CCDF.

Freq (GHz)	Pulse CW Signal ⁽¹⁾				$P_{avg}=50\text{dBm}$ WCDMA Signal ⁽²⁾		
	P3 (dBm)	P3 (W)	P4 (dBm)	P4 (W)	Gp (dB)	η_D (%)	ACPR _{5M} (dBc)
2.500	58.60	723	59.35	860	13.10	49.20	-29.20
2.600	59.08	806	59.32	855	13.45	49.21	-32.93
2.675	58.70	739	58.85	766	13.35	49.71	-34.35

Recommended driver: Doherty (1 stage discrete solution): STAV27100C6 or SMAV2527-100

Applications

- Asymmetrical Doherty amplifier within N41 5G band and B41 4G band
- S band power amplifier

Important Note: Proper Biasing Sequence for GaN HEMT Transistors

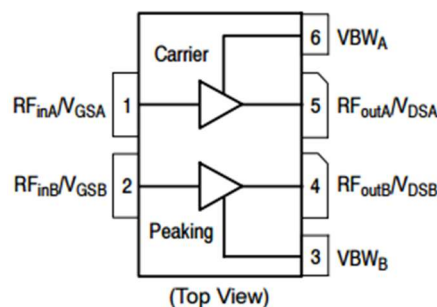
Turning the device ON

- Set VGS to the pinch-off (VP) voltage, typically -5 V
- Turn on VDS to nominal supply voltage
- Increase VGS until IDS current is attained
- Apply RF input power to desired level

Turning the device OFF

- Turn RF power off
- Reduce VGS down to VP, typically -5 V
- Reduce VDS down to 0 V
- Turn off VGS

1: Pin Connection definition



XTAV27750B4VC

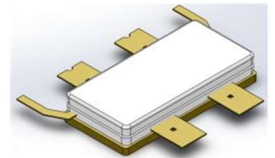




Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain—Source Voltage	V_{DS}	+200	Vdc
Gate—Source Voltage	V_{GS}	-8 to +0.5	Vdc
Operating Voltage	V_{DD}	55	Vdc
Maximum gate current	I_{gs}	92	mA
Storage Temperature Range	T_{stg}	-65 to +150	°C
Case Operating Temperature	T_C	+150	°C
Operating Junction Temperature	T_J	+225	°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value	Unit
Thermal Resistance, Junction to Case by FEA $T_C = 85^\circ\text{C}$, $P_{out} = 100\text{W}$, 2.6GHz Doherty application board	$R_{\theta JC}$	0.9	°C /W

Table 3. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

DC Characteristics (main path, measured on wafer prior to packaging)

Characteristic	Conditions	Symbol	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	$V_{GS} = -8\text{V}$; $I_{DS} = 38\text{mA}$	V_{DSS}		200		V
Gate Threshold Voltage	$V_{DS} = 10\text{V}$, $I_D = 38\text{mA}$	$V_{GS(th)}$	-4		-2	V
Gate Quiescent Voltage	$V_{DS} = 50\text{V}$, $I_{DS} = 280\text{mA}$, Measured in Functional Test	$V_{GS(Q)}$		-2.7		V

DC Characteristics (peak path, measured on wafer prior to packaging)

Characteristic	Conditions	Symbol	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	$V_{GS} = -8\text{V}$; $I_{DS} = 70\text{mA}$	V_{DSS}		200		V
Gate Threshold Voltage	$V_{DS} = 10\text{V}$, $I_D = 70\text{mA}$	$V_{GS(th)}$	-4		-2	V
Gate Quiescent Voltage	$V_{DS} = 50\text{V}$, $I_{DS} = 500\text{mA}$ Measured in Functional Test	$V_{GS(Q)}$		-2.7		V

Ruggedness Characteristics

Characteristic	Conditions	Symbol	Min	Typ	Max	Unit
Load mismatch capability	2.6GHz, $P_{out} = 100\text{W}$ WCDMA 1 Carrier in Doherty circuit All phase, No device damages	VSWR		10:1		



Figure 3: Efficiency and power gain as function of Pout (2.5-2.7GHz Doherty)

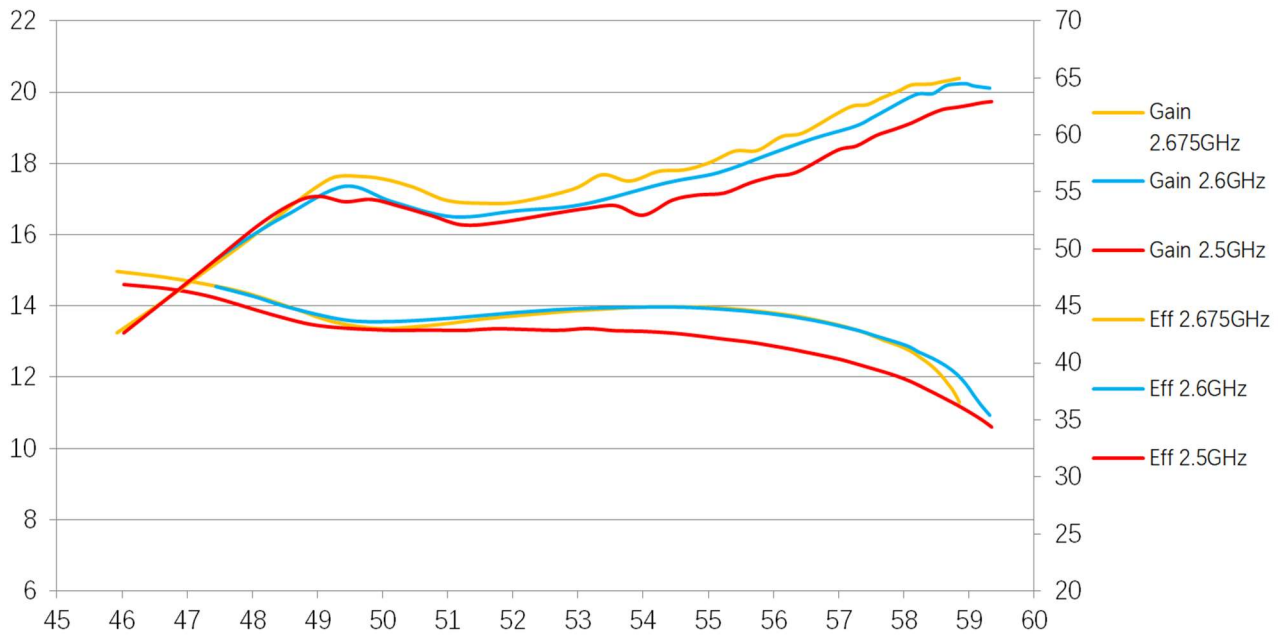


Figure 4: Network analyzer output, S11 and S21 (2.5-2.7GHz Doherty)

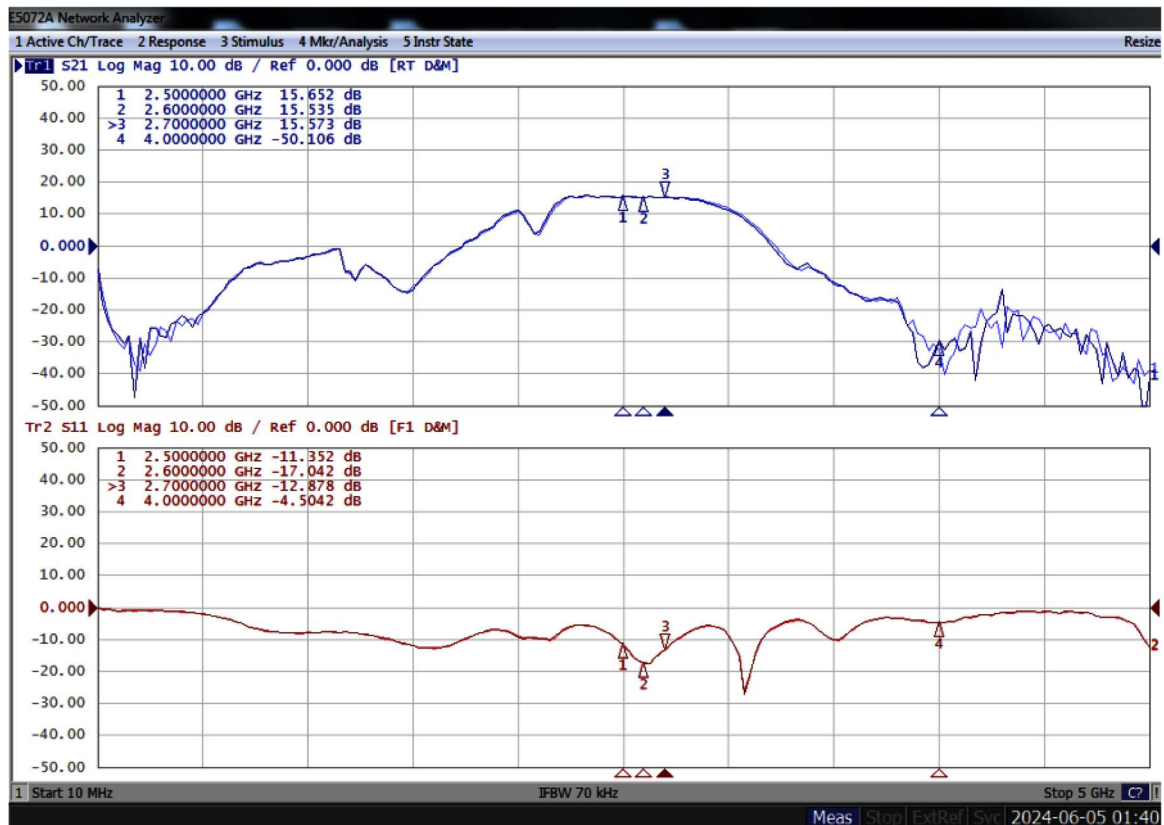


Figure 5: Picture of application board Doherty circuit for 2.5-2.7GHz

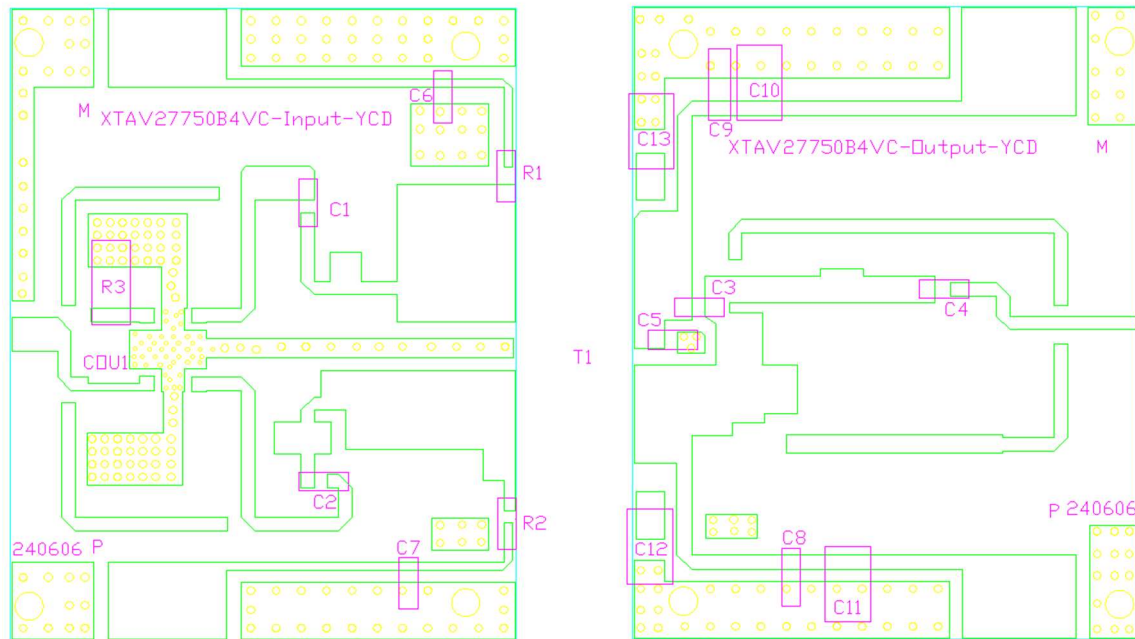
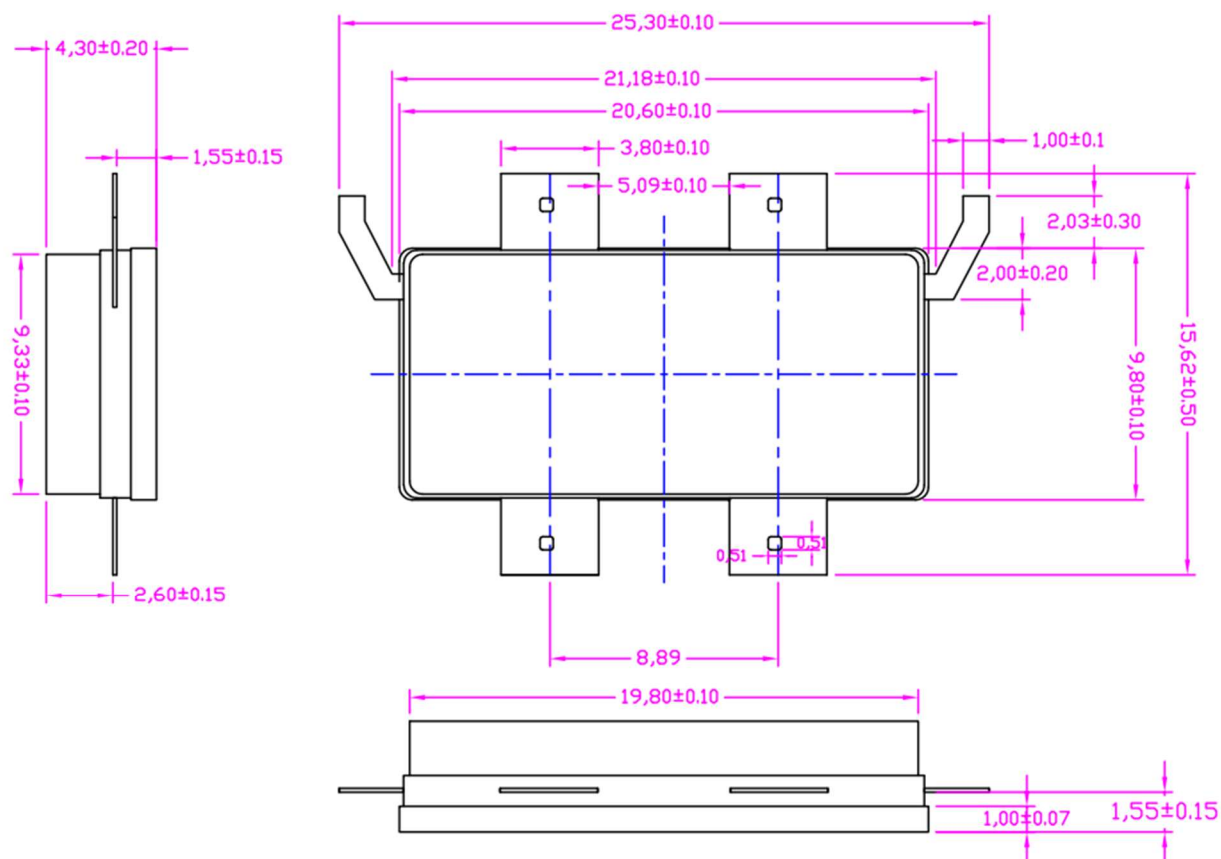


Table 4. Bill of materials of application board (PCB layout upon request, RO4350B 20mils)

Part	Quantity	Description	Part Number	Manufacture
C1,C2,C4, C6,C7,C8,C9	7	10pF High Q Capacitor	251SHS100BSE	TEMEX
C3	1	5.1pF High Q Capacitor	251SHF5R1BSE	TEMEX
C5	1	1.3pF High Q Capacitor	251SHS1R3BSE	TEMEX
C10,C11,C12,C13	4	10uF MLCC	GRM32EC72A10	Murata
R1,R2	2	10 Ω Power Resistor	ESR03EZPF100	ROHM
R3	1	50 Ω Power Resistor	S2512N	RN2
COU1	1	3 dB Bridge	X3C26P1-03S	Anaren
T1	1	750W GaN Dual Transistor	XTAV27750B4VC	Innogrations



Earless Flanged Ceramic Package; 6 leads- B4VC



Revision history

Table 4. Document revision history

Date	Revision	Datasheet Status
2024/6/5	V1.0	Advanced Datasheet Creation

Application data based on LWH-24-21

Notice

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